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FDC6327C

Dual N & P-Channel 2.5V Specified PowerTrench™ MOSFET

General Description

These N & P-Channel 2.5V specified MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain low gate charge for superior switching performance.

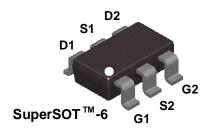
These devices have been designed to offer exceptional power dissipation in a very small footprint for applications where the bigger more expensive SO-8 and TSSOP-8 packages are impractical.

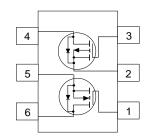
Applications

- DC/DC converter
- · Load switch
- Motor driving

Features

- N-Channel 2.7A, 20V. $R_{DS(on)} = 0.08\Omega$ @ $V_{GS} = 4.5V$ $R_{DS(on)} = 0.12\Omega$ @ $V_{GS} = 2.5V$
- P-Channel -1.6A, -20V.R_{DS(on)} = 0.17 Ω @ V_{GS} = -4.5V $R_{DS(on)} = 0.25\Omega$ @ V_{GS} = -2.5V
- Fast switching speed.
- · Low gate charge.
- \bullet High performance trench technology for extremely low $R_{\mbox{\tiny DS(ON)}}.$
- SuperSOT[™]-6 package: small footprint (72% smaller than SO-8); low profile (1mm thick).





60

Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		N-Channel	P-Channel	Units
V _{DSS}	Drain-Source Voltage		20	-20	V
V _{GSS}	Gate-Source Voltage		<u>±</u> 8	<u>+</u> 8	V
I _D	Drain Current - Continuous	(Note 1a)	2.7	-1.9	Α
	- Pulsed		8	-8	
P _D	Power Dissipation	(Note 1a)	0.9	96	W
		(Note 1b)	0	9	1
		(Note 1c)	0	.7	1
T _J , T _{stg}	Operating and Storage Junction Temperature Range		-55 to	+150	∘C
Therma	I Characteristics				
$R_{\theta^{JA}}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	13	30	°C/W

Package Marking and Ordering Information

Thermal Resistance, Junction-to-Case

T ackage marking and Ordering information							
Device Marking	Device	Reel Size	Tape Width	Quantity			
.327	FDC6327C	7"	8mm	3000			

(Note 1)

 $\mathsf{R}_{\theta^{\mathsf{JC}}}$

°C/W

Symbol	Parameter	Test Conditions	Type	Min	Тур	Max	Units
Off Cha	racteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	N-Ch P-Ch	20 -20			V
<u>A</u> BVnss ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, Referenced to 25°C $I_D = -250 \mu A$, Referenced to 25°C	N-Ch P-Ch		12 -19		mV/∘C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$	N-Ch P-Ch			1 -1	μΑ
I_{GSSF}	Gate-Body Leakage, Forward	$V_{GS} = 8 \text{ V}, V_{DS} = 0 \text{ V}$	All			100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	V _{GS} = -8 V, V _{DS} = 0 V	All			-100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	N-Ch	0.4	0.9	1.5	V
		$V_{DS} = V_{GS}, I_{D} = -250^{\circ} \mu A$	N-Ch P-Ch	0.4 -0.4	0.9 -0.9	1.5 -1.5	_
ΔVGS(th) ΔTJ	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C I_D = -250 μ A, Referenced to 25°C	N-Ch P-Ch		-2.1 2.3		mV/°C
R _{DS(on)}	Static Drain-Source On-Resistance	$\begin{split} &V_{GS} = 4.5 \text{ V}, \ I_D = 2.7 \text{ A} \\ &V_{GS} = 4.5 \text{ V}, \ I_D = 2.7 \text{ A}, \ T_J = 125 ^{\circ}\text{C} \\ &V_{GS} = 2.5 \text{ V}, \ I_D = 2.2 \text{ A} \\ &V_{GS} = -4.5 \text{ V}, \ I_D = -1.6 \text{ A} \\ &V_{GS} = -4.5 \text{ V}, \ I_D = -1.6 \text{ A}, \ T_J = 125 ^{\circ}\text{C} \\ &V_{GS} = -2.5 \text{ V}, \ I_D = -1.3 \text{ A} \end{split}$	N-Ch N-Ch N-Ch P-Ch P-Ch		0.069 0.094 0.093 0.141 0.203 0.205	0.08 0.13 0.12 0.17 0.27 0.25	Ω
$I_{D(on)}$	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$ $V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$	N-Ch P-Ch	8 -8			Α
g FS	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_D = 2.7 \text{ A}$ $V_{DS} = -5 \text{ V}, I_D = -1.9 \text{ A}$	N-Ch P-Ch		7.7 4.5		S
Dynami	c Characteristics						
C _{iss}	Input Capacitance	N-Channel V _{DS} = 10 V, V _{GS} = 0 V, f = 1.0 MHz	N-Ch P-Ch		325 315		pF
C _{oss}	Output Capacitance	P-Channel	N-Ch P-Ch		75 65		pF
C _{rss}	Reverse Transfer Capacitance	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	N-Ch P-Ch		35 24		pF

Electrical Characteristics	(continued)	T _A = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Туре	Min	Typ	Max	Units		
Switchir	Switching Characteristics (Note 2)								
t _{d(on)}	Turn-On Delay Time	N-Channel $V_{DD} = 10 \text{ V}, I_D = 1 \text{ A},$	N-Ch P-Ch		5 7	15 14	ns		
t _r	Turn-On Rise Time	$V_{GS} = 4.5V$, $R_{GEN} = 6 \Omega$	N-Ch P-Ch		9 14	18 25	ns		
$t_{\text{d(off)}}$	Turn-Off Delay Time	P-Channel $V_{DD} = -10 \text{ V}, I_D = -1 \text{ A},$	N-Ch P-Ch		12 14	22 25	ns		
t _f	Turn-Off Fall Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$	N-Ch P-Ch		3 3	9 9	ns		
Q _g	Total Gate Charge	N-Channel $V_{DS} = 10 \text{ V}, I_{D} = 2.7 \text{ A}, V_{GS} = 4.5 \text{V}$	N-Ch P-Ch		3.25 2.85	4.5 4.0	nC		
Q_{gs}	Gate-Source Charge	P-Channel	N-Ch P-Ch		0.65 0.68		nC		
Q_{gd}	Gate-Drain Charge	$V_{DS} = -10 \text{ V}, I_{D} = -1.9 \text{ A}, V_{GS} = -4.5 \text{V}$	N-Ch P-Ch		0.90 0.65		nC		

Drain-Source Diode Characteristics and Maximum Ratings

<u> </u>	Prairi Coaro Prode Criaractoriotico aria maximani ratirigo					
Is	Maximum Continuous Drain-Source Diode Forward Current	N-Ch		0.8	Α	
		P-Ch		-0.8		
V_{SD}	Drain-Source Diode Forward $V_{GS} = 0 \text{ V}, I_S = 0.8 \text{ A}$ (Note 2)	N-Ch	0.76	1.2	V	
	Voltage $V_{GS} = 0 \text{ V. } I_S = -0.8 \text{ A} \text{ (Note 2)}$	P-Ch	-0.79	-1.2		

Notes:

1: R_{e,JA} is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.

R_{e,JC} is guaranteed by design while R_{e,JA} is determined by the user's board design. Both devices are assumed to be operating and sharing the dissipated heat energy equally.



a) 130 °C/W when mounted on a 0.125 in² pad of 2 oz. copper.



b) 140 °C/W when mounted on a 0.005 in² pad of 2 oz. copper.



c) 180 °C/W when mounted on a 0.0015 in² pad of 2 oz. copper.

Scale 1: 1 on letter size paper

2: Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%

Typical Characteristics: N-Channel

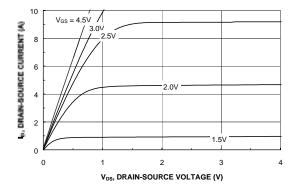


Figure 1. On-Region Characteristics.

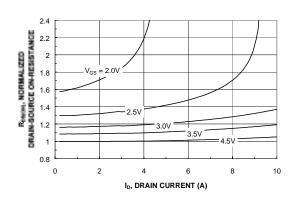


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

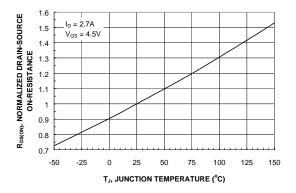


Figure 3. On-Resistance Variation with Temperature.

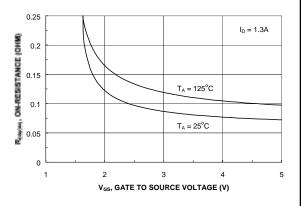


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

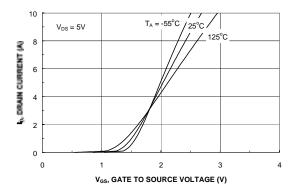


Figure 5. Transfer Characteristics.

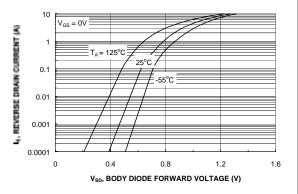
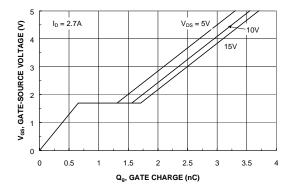


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: N-Channel (continued)



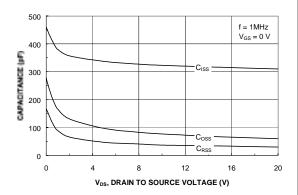
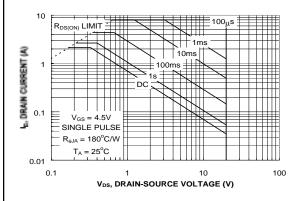


Figure 7. Gate-Charge Characteristics.

Figure 8. Capacitance Characteristics.



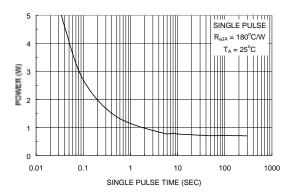
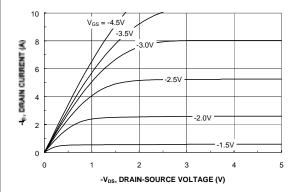


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

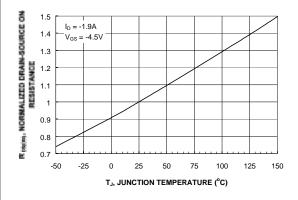
Typical Characteristics: P-Channel



2.4 2.2 V_{GS} = -2.0V -2.5V 1.6 1.4 1.2 1 0.8 0 2 4 6 8 10 -1₀, DIRAIN CURRENT (A)

Figure 11. On-Region Characteristics.

Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.



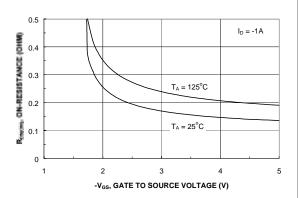
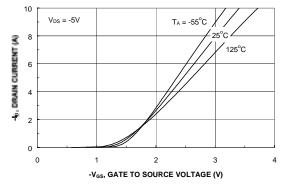


Figure 13. On-Resistance Variation with Temperature.

Figure 14. On-Resistance Variation with Gate-to-Source Voltage.



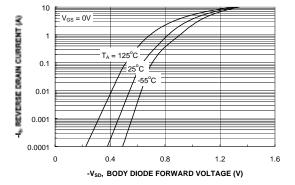
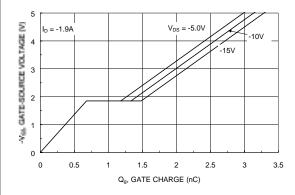


Figure 15. Transfer Characteristics.

Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: P-Channel (continued)



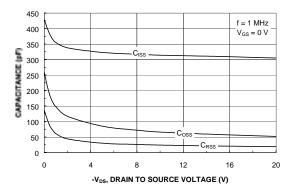
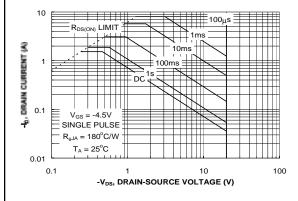


Figure 17. Gate-Charge Characteristics.

Figure 18. Capacitance Characteristics.



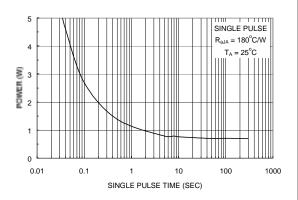


Figure 19. Maximum Safe Operating Area.

Figure 20. Single Pulse Maximum Power Dissipation.

Typical Characteristics: N & P-Channel (continued)

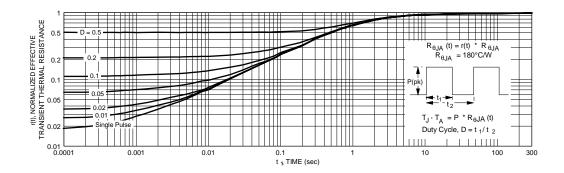


Figure 21. Transient Thermal Response Curve.

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